Application No.: 10/693,460 Docket No.: M1071.1873/P1873

## AMENDMENTS TO THE CLAIMS

- 1 4 (Cancelled).
- 5. (Concurrently Amended) A production method for a laminated type <u>positive</u> <u>temperature-resistance</u> semiconductor ceramic element comprising

providing a mixture comprising a barium compound, a titanium compound and a nickel compound,

calcining the mixture to obtain a calcined product;

forming a ceramic green sheet comprising the calcined product;

applying a conductive paste for forming an internal electrode layer of the laminated type semiconductor ceramic element on the ceramic green sheet;

laminating the ceramic green sheet so as to provide a laminated product; and

baking the laminated product under a reducing atmosphere <u>and reoxidizing the baked</u> <u>laminate</u> so as to form a laminated <u>positive temperature-resistance</u> semiconductor ceramic elemen.

- 6. (Previously Presented) The production method of claim 5 wherein the mixture calcined contains a boron compound.
- 7. (Previously Presented)) The production method of claim 6 wherein the boron compound is about 0.2 to 20 mol%.
- 8. (Previously Presented) The production method of claim 7 wherein the nickel compound is present in the mixture in a positive amount up to about 0.2 mol%.

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9. (Previously Presented) The production method of claim 8 wherein an external electrode electrically conducted to the internal electrode is formed on the laminated semiconductor ceramic element.

## 10. (Cancelled)

- 11. (Currently Amended) The production method according to claim  $\frac{10}{9}$  wherein the laminated product is baked at a temperature of 900 to 1300°C for 0.5 to 5 hours.
- 12. (Previously Presented) The production method according to claim 11 wherein the conductive paste contains nickel.
- 13. (Previously Presented) The production method according to claim 12 comprising forming the mixture of the barium compound, titanium compound and nickel compound.
- 14. (Previously Presented) The production method of claim 5 wherein the nickel compound is present in the mixture in a positive amount up to about 0.2 mol%.
- 15. (Previously Presented) The production method of claim 14 wherein an external electrode electrically conducted to the internal electrode is formed on the laminated semiconductor ceramic element.

## 16. (Cancelled).

- 17. (Currently Amended) The production method according to claim 16 15 wherein the laminated product is baked at a temperature of 900 to 1300°C for 0.5 to 5 hours.
- 18. (Previously Presented) The production method according to claim 17 wherein the conductive paste contains nickel.

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19. (Previously Presented) The production method according to claim 18 comprising forming the mixture of the barium compound, titanium compound and nickel compound.

- 20. (Previously Presented) The production method of claim 5 in which an external electrode electrically conducted to the internal electrode is formed on the laminated semiconductor ceramic element.
  - 21. (Cancelled).
- 22. (Previously Presented) The production method according to claim 5 wherein the laminated product is baked at a temperature of 900 to 1300°C for 0.5 to 5 hours.
- 23. (Previously Presented) The production method according to claim 5 wherein the conductive paste contains nickel.
- 24. (Previously Presented) The production method according to claim 5 comprising forming the mixture of the barium compound, titanium compound and nickel compound.